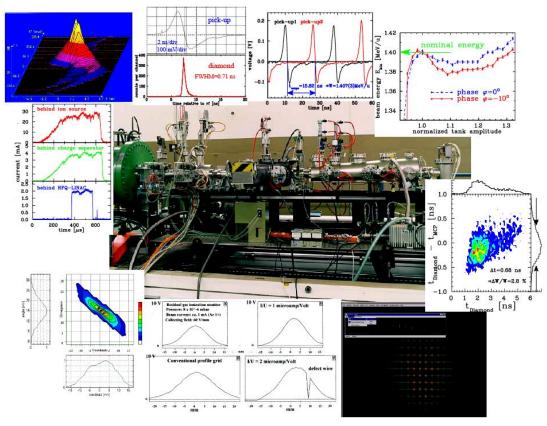
# Beam Diagnostics and Instrumentation JUAS 2016, Archamps Peter Forck

#### Gesellschaft für Schwerionenforschnung (GSI) and University Frankfurt



Demands for Beam Diagnostics

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- Quick, non-destructive measurements leading to a single number or simple plots Used as a check for online information. Reliable technologies have to be used *Example:* Current measurement by transformers
- Instruments for daily check, malfunction diagnosis and wanted parameter variation *Example*: Profile measurement, in many cases 'intercepting' i.e destructive to the beam
- Complex instruments for severe malfunctions, accelerator commissioning & development The instrumentation might be destructive and complex *Example:* Emittance determination
- General usage of beam instrumentation:
- Monitoring of beam parameters for operation, beam alignment, acc. development.....
- Instruments for automatic, active beam control

*Example:* Closed orbit feedback using position measurement by BPMs

#### Non-destructive ('non-intercepting') methods are preferred:

- $\succ$  The beam is not influenced
- The instrument is not destroyed

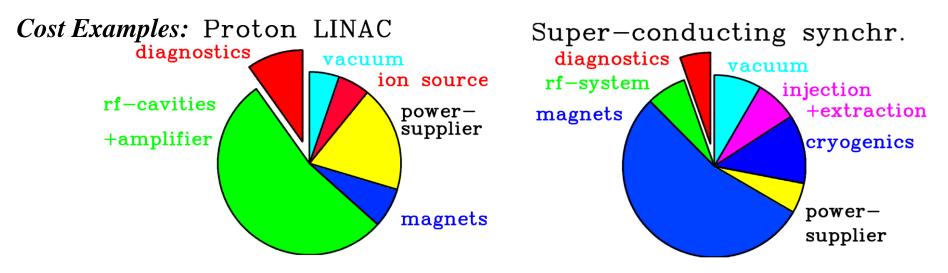
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## The Role of Beam Diagnostics



#### The cost of diagnostics is about 3 to 10 % of the total facility cost:

- $\geq 3$  % for large accelerators *or* accelerators with standard technologies
- $\geq \approx 10$  % for versatile accelerators *or* novel accelerators and technologies.



## The amount of man-power is about 10 to 20 %:

- ➤ very different physics and technologies are applied
- ➤ technologies have to be up-graded, e.g. data acquisition and analysis
- $\succ$  accelerator improvement calls for new diagnostic concepts.

## **Relevant physical Processes for Beam Diagnostics**

- Electro-magnetic influence by moving charges:
  - $\rightarrow$  <u>Physics</u>: classical electro-dynamics. <u>Technique</u>: *U* and *I* meas., low & high frequencies *Examples*: Faraday cups, beam transformers, pick-ups
- **Emission of photon by accelerated charges:** (only for high relativistic electrons and p)
  - → <u>Physics</u>: classical electro-dynamics. <u>Technique</u>: optical techniques (from visible to x-ray) *Example*: Synchrotron radiation monitors
- > Interaction of particles with photons:
  - $\rightarrow$  <u>Physics</u>: optics, lasers. <u>Technique</u>: optical techniques, particle detectors *Examples:* laser scanners, short bunch length measurement, polarimeters
- > Coulomb interaction of charged particles with matter:
- $\rightarrow$  <u>Physics</u>: atomic and solid state physics. <u>Technique</u>: *I* meas., optics, particle detectors *Examples:* scintillators, viewing screens, ionization chambers, residual gas monitors
- > Nuclear- or elementary particle physics interactions:
  - $\rightarrow$  <u>Physics</u>: nuclear physics. <u>Technique</u>: particle detectors
  - Examples: beam loss monitors, polarimeters, luminosity monitors
- And of cause accelerator physics for proper instrumentation layout.
   Beam diagnostics deals with the full spectrum of physics and technology,
   ⇒ this calls for experts on all these fields and is a challenging task!

**LINAC & transport lines**: Single pass  $\leftrightarrow$  **Synchrotron:** multi pass **Electrons:** always relativistic  $\leftrightarrow$  **Protons/Ions:** non-relativistic for  $E_{kin} < 1$  GeV/u **Depending on application:** Low current  $\leftrightarrow$  high current

**Overview of the most commonly used systems:** 

Beam quantity		LINAC & transfer line	Synchrotron
Current I	General	Transformer, dc & ac	Transformer, dc & ac
		Faraday Cup	
	Special	<b>Particle Detectors</b>	Pick-up Signal (relative)
Profile <i>x<sub>width</sub></i>	General	Screens, SEM-Grids	Ionization Profile Monitor
		Wire Scanners, OTR Screen	Wire Scanner,
			Synchrotron Light Monitor
	Special	MWPC, Fluorescence Light	
Position <i>x<sub>cm</sub></i>	General	Pick-up (BPM)	Pick-up (BPM)
	Special	Using position measurement	
Transverse Emittance <i>\varepsilon_trans</i>	General	Slit-grid	Ionization Profile Monitor
		Quadrupole Variation	Wire Scanner
	Special	Pepper-Pot	Transverse Schottky

#### Beam Quantities and their Diagnostics II

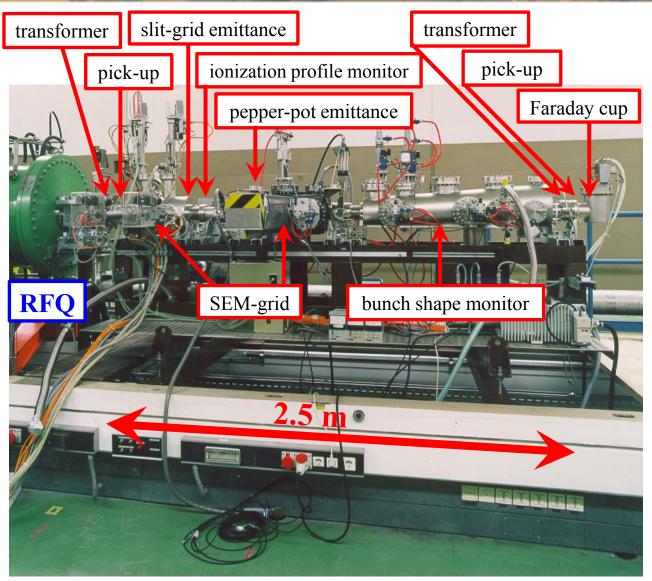
Beam quantity		LINAC & transfer line	Synchrotron
Bunch Length Δφ	General	Pick-up	Pick-up
	Special	Secondary cleatrong arrival	Wall Current Monitor Streak Camera
	Special	Secondary electrons arrival Electro-optical laser mod.	Electro-optical laser mod.
Momentum <i>p</i> and	General	Pick-ups (Time-of-Flight)	Pick-up (e.g. tomography)
Momentum Spread <i>Ap/p</i>	Special	Magnetic Spectrometer	Schottky Noise Spectrum
Longitudinal Emittance	General	<b>Buncher variation</b>	
<sup>E</sup> long	Special	Magnetic Spectrometer	Pick-up & tomography
Tune and Chromaticity $Q, \xi$	General		Exciter + Pick-up
	Special		Transverse Schottky Spectrum
Beam Loss r <sub>loss</sub>	General	Particle Detectors	
Polarization <i>P</i>	General	Particle Detectors	
	Special	Laser Scattering (Compton scattering)	
Luminocity <i>L</i>	General	Particle Detectors	

>Destructive and non-destructive devices depending on the beam parameter.

 $\succ$  Different techniques for the same quantity  $\leftrightarrow$  Same technique for the different quantities.

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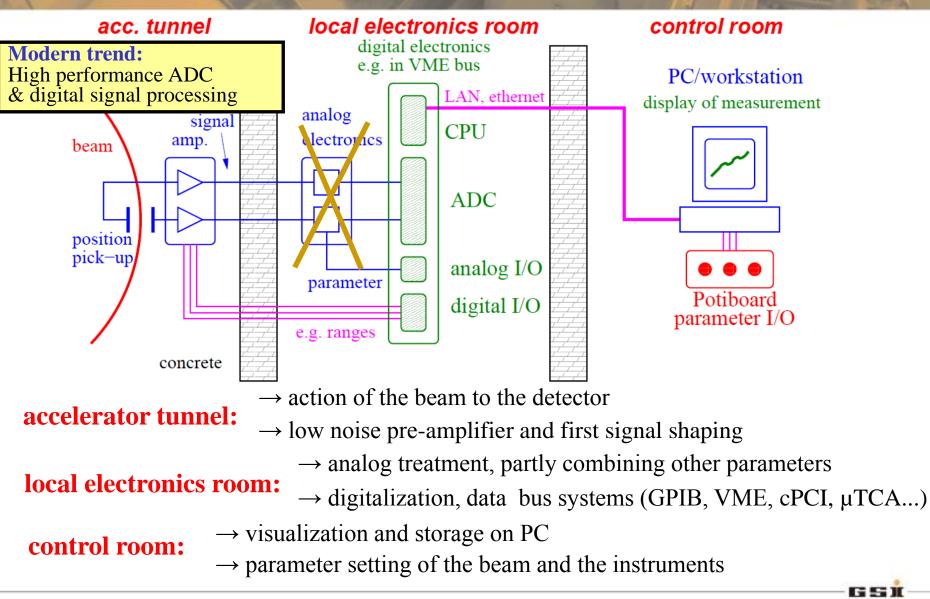
#### Example: Diagnostics Bench for the Commissioning of an RFQ



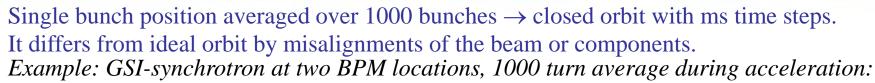
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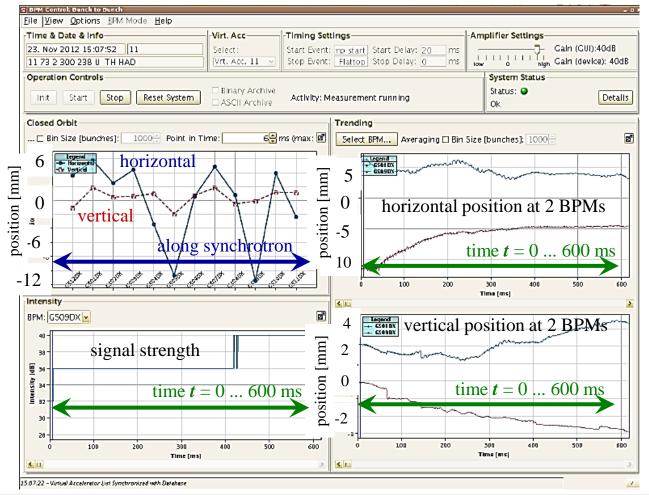
Demands for Beam Diagnostics

# Typical Installation of a Diagnostics Device



#### **Close Orbit Measurement with BPMs**





#### **Closed orbit:**

Beam position averaged over many turns (i.e. betatron oscillations).

The result helps to align the accelerator! Some device parameters are shown to prove functionality.

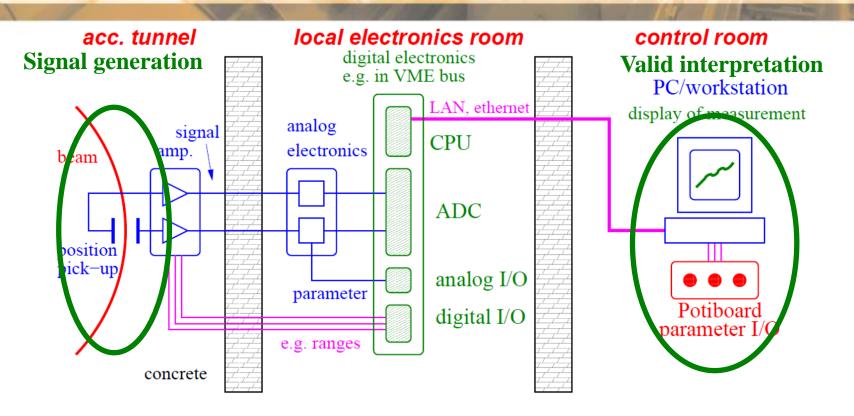
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- The ordering of the subjects is oriented by the beam quantities:
- Current measurement: Transformers, cups, particle detectors
- Profile measurement: Various methods depending on the beam properties
- Transverse emittance measurement: Destructive devices, determination by linear transformations
- Pick-ups for bunched beams: Principle and realization of rf pick-ups, closed orbit and tune measurements
- Measurement of longitudinal parameters: Beam energy with pick-ups, time structure of bunches for low and high beam energies, longitudinal emittance
- Beam loss detection: Secondary particle detection for optimization and protection
- It will be discussed: The action of the beam to the detector, the design of the devices, generated raw data, partly analog electronics, results of the measurements.
  It will not be discussed: Detailed signal-to-noise calculations, analog electronics, digital electronics, data acquisition and analysis, online and offline software....
  General: Standard methods and equipment for stable beams with moderate intensities.

# Goal of the Lecture



The goal of the lecture should be:

- Understanding the signal generation of various device
- Showing examples for real beam behavior
- > Enabling a correct interpretation of various measurements.

#### The Accelerator Facility at GSI

The GSI linear accelerator, synchrotron & storage ring for heavy ions

